



TEST REPORT

Product Trade mark Model/Type reference **Serial Number Report Number** FCC ID Date of Issue **Test Standards Test result**

- Chipper BT
- **BBPOS**

:

- Chipper BT
- N/A
- EED32100206702
- : 2AB7X-CHIPPERBT
- Aug. 29, 2016
- 47 CFR Part 15Subpart C (2015)

: PASS

Prepared for: **BBPOS International Limited** Suite 1602, 16/F, Tower 2, Nina Tower, No. 8 Yeung Uk Road, Tsuen Wan, N.T. HK

Prepared by:

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Check No.: 2392182047





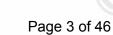
2 Version

Version No.	Date	le l	Description)
00	Aug. 29, 2016		Original	
	-	1	(°>>	1
		(dS)		





3 Test Summary



Test Item	Test Requirement	Test method	Result
Antenna Requirement	47 CFR Part 15Subpart C Section 15.203/15.247 (c)	ANSI C63.10-2013	PASS
AC Power Line Conducted Emission	47 CFR Part 15Subpart C Section 15.207	ANSI C63.10-2013	PASS
Conducted Peak Output Power	47 CFR Part 15Subpart C Section 15.247 (b)(3)	ANSI C63.10-2013/ KDB 558074 D01v03r05	PASS
6dB Occupied Bandwidth	47 CFR Part 15Subpart C Section 15.247 (a)(2)	ANSI C63.10-2013/ KDB 558074 D01v03r05	PASS
Power Spectral Density	47 CFR Part 15Subpart C Section 15.247 (e)	ANSI C63.10-2013/ KDB 558074 D01v03r05	PASS
Band-edge for RF Conducted Emissions	47 CFR Part 15Subpart C Section 15.247(d)	ANSI C63.10-2013/ KDB 558074 D01v03r05	PASS
RF Conducted Spurious Emissions	47 CFR Part 15Subpart C Section 15.247(d)	ANSI C63.10-2013/ KDB 558074 D01v03r05	PASS
Radiated Spurious Emissions	47 CFR Part 15Subpart C Section 15.205/15.209	ANSI C63.10-2013	PASS
Restricted bands around fundamental frequency (Radiated Emission)	47 CFR Part 15Subpart C Section 15.205/15.209	ANSI C63.10-2013	PASS

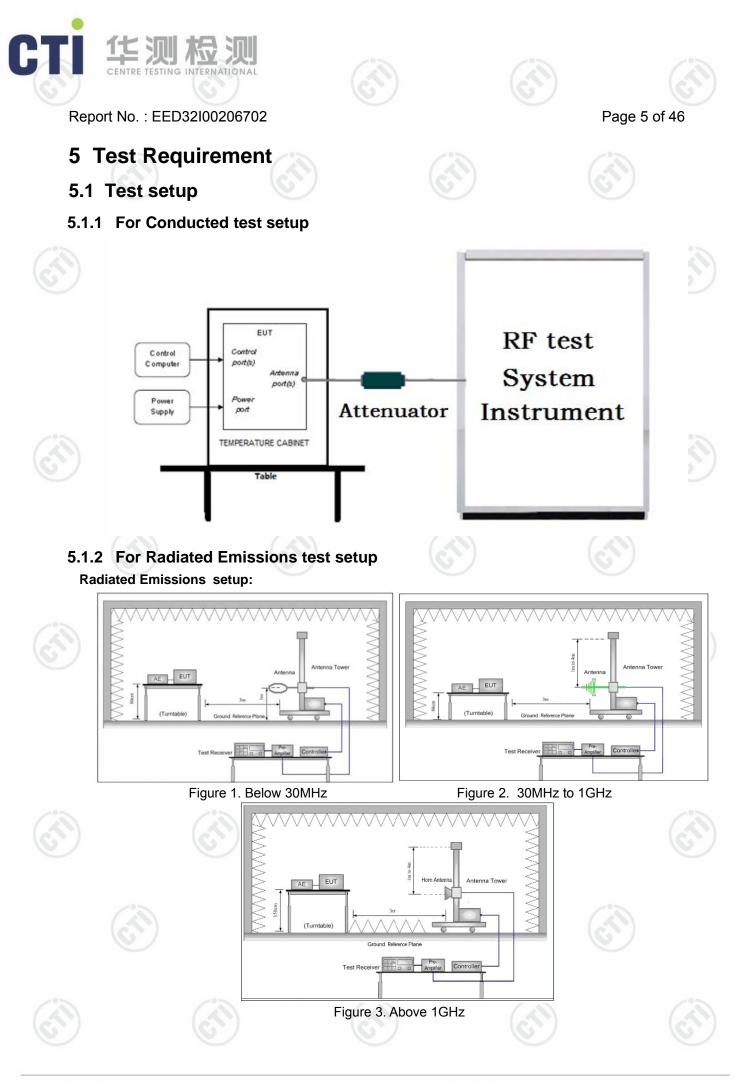
Test according to ANSI C63.4-2014 & ANSI C63.10-2013. The tested sample and the sample information are provided by the client.





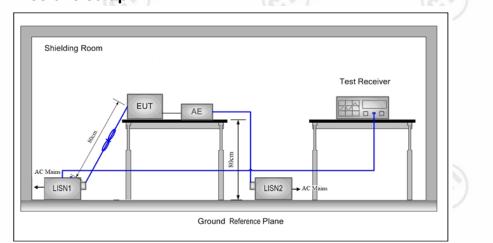


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)		





5.1.3 For Conducted Emissions test setup Conducted Emissions setup



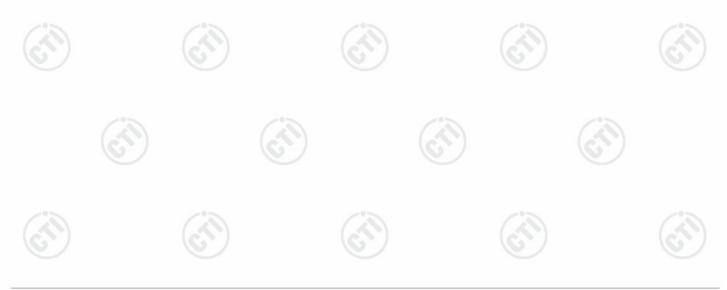
5.2 Test Environment

Operating Environment:		U	e
Temperature:	22°C		
Humidity:	54% RH		
Atmospheric Pressure:	1010mbar		0
(0.7)	(C.) (C.		

5.3 Test Condition

Test channel:

Test Mede	т.		RF Channel	
Test Mode		Low(L)	Middle(M)	High(H)
OFOK		Channel 1	Channel 20	Channel 40
GFSK	2402MHz ~2480 MHz	2402MHz	2440MHz	2480MHz
Transmitting mode:	Keep the EUT in transmitting mod data rate.	de with all kind of	f modulation and	all kind of











General Information 6

6.1 Client Information

Applicant:	BBPOS International Limited
Address of Applicant:	Suite 1602, 16/F, Tower 2, Nina Tower, No. 8 Yeung Uk Road, Tsuen Wan, N.T. HK
Manufacturer:	BBPOS International Limited
Address of Manufacturer:	Suite 1602, 16/F, Tower 2, Nina Tower, No. 8 Yeung Uk Road, Tsuen Wan, N.T. HK
Factory:	BBPOS International Limited
Address of Factory:	Suite 1602, 16/F, Tower 2, Nina Tower, No. 8 Yeung Uk Road, Tsuen Wan, N.T. HK

6.2 General Description of EUT

Product Name:	Chipper BT		
Model No.(EUT):	Chipper BT	~°>>	~>>
Trade Mark:	BBPOS	(\mathcal{A})	(5)
EUT Supports Radios application:	2402MHz-2480MHz		
Power Supply:	Lithium battery:3.7V, 125mAh		
USB cable:	150mm(Unshield)		
Sample Received Date:	Jul. 20, 2016		6.
Sample tested Date:	Jul. 20, 2016 to Aug. 29, 2016		

6.3 Product Specification subjective to this standard

Operation Frequency:	2402MHz~2480MHz		
Bluetooth Version:	4.0		S
Modulation Technique:	DSSS		
Modulation Type:	GFSK		
Number of Channel:	40		
Sample Type:	Portable production	O	
Test Power Grade:	N/A(manufacturer declare)		
Test Software of EUT:	BTChipper-1.00.00.02.exe (manufacturer c	leclare)	
Antenna Type:	Printed Antenna		
Antenna gain:	4dBi	S)	G
Test Voltage:	AC 120V/60Hz, AC 240V/50Hz, DC 3.7V		

Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
1	2402MHz	11	2422MHz	21	2442MHz	31	2462MHz
2	2404MHz	12	2424MHz	22	2444MHz	32	2464MHz
3	2406MHz	13	2426MHz	23	2446MHz	33	2466MHz
4	2408MHz	14	2428MHz	24	2448MHz	34	2468MHz





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5	2410MHz	15	2430MHz	25	2450MHz	35	2470MHz
6	2412MHz	16	2432MHz	26	2452MHz	36	2472MHz
7	2414MHz	17	2434MHz	27	2454MHz	37	2474MHz
8	2416MHz	18	2436MHz	28	2456MHz	38	2476MHz
9	2418MHz	19	2438MHz	29	2458MHz	39	2478MHz
10	2420MHz	20	2440MHz	30	2460MHz	40	2480MHz

6.4 Description of Support Units

The EUT has been tested with associated equipment below.

Associat	ed equipment name	Manufacture	Model	Serial number	Supplied by
AE1	laptop computer	Lenovo	E46L	EB22995690	Сті
AE2	mouse	a4tech	OP-520-NU	NA	СТІ

6.5 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd. Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China 518101 Telephone: +86 (0) 755 33683668 Fax:+86 (0) 755 33683385 No tests were sub-contracted.

6.6 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:



CNAS-Lab Code: L1910

Centre Testing International Group Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories..

A2LA-Lab Cert. No. 3061.01

Centre Testing International Group Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

FCC-Registration No.: 886427

Centre Testing International Group Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 886427.

IC-Registration No.: 7408A-2

The 3m Alternate Test Site of Centre Testing International Group Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 7408A-2.

IC-Registration No.: 7408B-1









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The 10m Alternate Test Site of Centre Testing International Group Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 7408B-1.

NEMKO-Aut. No.: ELA503

Centre Testing International Group Co., Ltd. has been assessed the quality assurance system, the testing facilities, qualifications and testing practices of the relevant parts of the organization. The quality assurance system of the Laboratory has been validated against ISO/IEC 17025 or equivalent. The laboratory also fulfils the conditions described in Nemko Document NLA-10.

VCCI

The Radiation 3 &10 meters site of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-4096. Main Ports Conducted Interference Measurement of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: C-4563.

Telecommunication Ports Conducted Disturbance Measurement of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: T-2146.

The Radiation 3 meters site of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-758

6.7 Deviation from Standards

None.

6.8 Abnormalities from Standard Conditions

None.

6.9 Other Information Requested by the Customer

None.

6.10 Measurement Uncertainty (95% confidence levels, k=2)

No.	Item	Measurement Uncertainty
1	Radio Frequency	7.9 x 10 ⁻⁸
2	PE nower, conducted	0.31dB (30MHz-1GHz)
2	RF power, conducted	0.57dB (1GHz-18GHz)
3	Dedicted Sources optication test	4.5dB (30MHz-1GHz)
S	Radiated Spurious emission test	4.8dB (1GHz-12.75GHz)
4	Conduction emission	3.6dB (9kHz to 150kHz)
4	Conduction emission	3.2dB (150kHz to 30MHz)
5	Temperature test	0.64°C
6	Humidity test	2.8%
7	DC power voltages	0.025%



7 Equipment List

		RF test	system		
Equipment	Manufacturer	Mode No.	Serial Number	Cal. Date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)
Signal Generator	Keysight	E8257D	MY53401106	04-01-2016	03-31-2017
Communication test set	Agilent	N4010A	MY51400230	04-01-2016	03-31-2017
Spectrum Analyzer	Keysight	N9010A	MY54510339	04-01-2016	03-31-2017
Signal Generator	Keysight	N5182B	MY53051549	04-01-2016	03-31-2017
High-pass filter	Sinoscite	FL3CX03WG18 NM12-0398-002		01-12-2016	01-11-2017
High-pass filter	MICRO- TRONICS	SPA-F-63029-4	0	01-12-2016	01-11-2017
DC Power	Keysight	E3642A	MY54436035	04-01-2016	03-31-2017
PC-1	Lenovo	R4960d		04-01-2016	03-31-2017
BT&WI-FI Automatic control	R&S	OSP120	101374	04-01-2016	03-31-2017
RF control unit	JS Tonscend	JS0806-2	158060006	04-01-2016	03-31-2017
BT&WI-FI Automatic test software	JS Tonscend	JS1120-2		04-01-2016	03-31-2017

	Cor	nducted distur	bance Test		
Equipment	Manufacturer	Mode No.	Serial Number	Cal. date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)
Receiver	R&S	ESCI	100009	06-16-2016	06-15-2017
Temperature/ Humidity Indicator	TAYLOR	1451	1905	04-27-2016	04-26-2017
Communication test set	Agilent	E5515C	GB47050534	04-01-2016	03-31-2017
Communication test set	R&S	CMW500	152394	04-01-2016	03-31-2017
LISN	R&S	ENV216	100098	06-16-2016	06-15-2017
LISN	schwarzbeck	NNLK8121	8121-529	06-16-2016	06-15-2017
Voltage Probe	R&S	ESH2-Z3		07-09-2014	07-07-2017
Current Probe	R&S	EZ17	100106	06-16-2016	06-15-2017
ISN	TESEQ GmbH	ISN T800	30297	01-29-2015	01-27-2017
	N. 1				6.

















	3M :	Semi/full-anech	oic Chamber		
Equipment	Manufacturer	Mode No.	Serial Number	Cal. date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)
3M Chamber & Accessory Equipment	ТДК	SAC-3		06-05-2016	06-05-2019
TRILOG Broadband Antenna	SCHWARZBEC K	VULB9163	9163-484	05-23-2016	05-22-2017
Microwave Preamplifier	Agilent	8449B	3008A02425	02-04-2016	02-03-2017
Horn Antenna	ETS-LINDGREN	3117	00057407	07-20-2015	07-18-2018
Loop Antenna	ETS	6502	00071730	07-30-2015	07-28-2017
Spectrum Analyzer	R&S	FSP40	100416	06-16-2016	06-15-2017
Receiver	R&S	ESCI	100435	06-16-2016	06-15-2017
Multi device Controller	maturo	NCD/070/10711 112		01-12-2016	01-11-2017
LISN	schwarzbeck	NNBM8125	81251547	06-16-2016	06-15-2017
LISN	schwarzbeck	NNBM8125	81251548	06-16-2016	06-15-2017
Signal Generator	Agilent	E4438C	MY45095744	04-01-2016	03-31-2017
Signal Generator	Keysight	E8257D	MY53401106	04-01-2016	03-31-2017
Temperature/ Humidity Indicator	TAYLOR	1451	1905	04-27-2016	04-26-2017
Communication test set	Agilent	E5515C	GB47050534	04-01-2016	03-31-2017
Cable line	Fulai(7M)	SF106	5219/6A	01-12-2016	01-11-2017
Cable line	Fulai(6M)	SF106	5220/6A	01-12-2016	01-11-2017
Cable line	Fulai(3M)	SF106	5216/6A	01-12-2016	01-11-2017
Cable line	Fulai(3M)	SF106	5217/6A	01-12-2016	01-11-2017
Communication test set	R&S	CMW500	152394	04-01-2016	03-31-2017
High-pass filter	Sinoscite	FL3CX03WG18 NM12-0398-002		01-12-2016	01-11-2017
High-pass filter	MICRO- TRONICS	SPA-F-63029-4		01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX01CA09 CL12-0395-001		01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX01CA08 CL12-0393-001		01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX02CA04 CL12-0396-002		01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX02CA03 CL12-0394-001		01-12-2016	01-11-2017















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8 Radio Technical Requirements Specification

Reference documents for testing:

No.	Identity			Document Title				
1	FCC Part15C (2015	5)	Subpart C	-Intentional Radiators				
2	ANSI C63.10-2013	3 American National Standard for Testing Unlicesed Wireless Devices						
est R	esults List:		Q		1	e		
	Test Requirement	Tes	t method	Test item	Verdict	Note		
(Part15C Section 15.247 (a)(2)	ANS	SI C63.10	6dB Occupied Bandwidth	PASS	Appendix A		
	Part15C Section 15.247 (b)(3)	ANS	SI C63.10	Conducted Peak Output Power	PASS	Appendix B		
	Part15C Section 15.247(d)	ANS	6I C63.10	Band-edge for RF Conducted Emissions	PASS	Appendix C		
	Part15C Section 15.247(d)	ANS	GI C63.10	RF Conducted Spurious Emissions	PASS	Appendix D		
Part	15C Section 15.247 (e)	ANS	SI C63.10	Power Spectral Density	PASS	Appendix E		
	Part15C Section 15.203/15.247 (c)	ANS	SI C63.10	Antenna Requirement	PASS	Appendix F		
	Part15C Section 15.207	ANS	6I C63.10	AC Power Line Conducted Emission	PASS	Appendix G		
	Part15C Section 15.205/15.209	ANS	SI C63.10	Restricted bands around fundamental frequency (Radiated Emission)	PASS	Appendix H		
	Part15C Section 15.205/15.209	ANS	GI C63.10	Radiated Spurious Emissions	PASS	Appendix I		



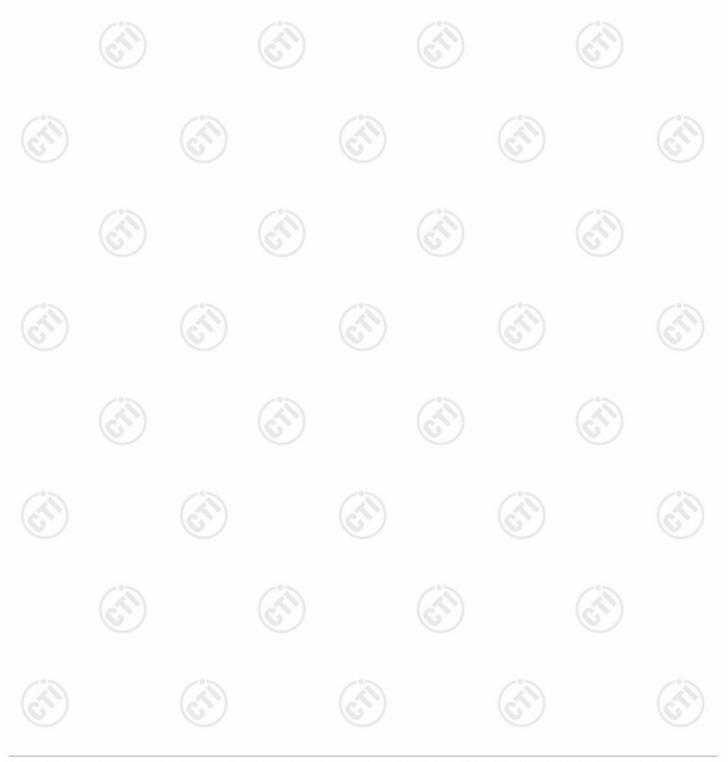






Appendix A): 6dB Occupied Bandwidth

	Test Resu	lt		U		
	Mode	Channel	6dB Bandwidth [MHz]	99% OBW[MHz]	Verdict	Remark
13	BLE	LCH	0.6612	1.0597	PASS	
6	BLE	MCH	0.6569	1.0557	PASS	Peak
1 al	BLE	НСН	0.6542	1.0548	PASS	detector







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Appendix B): Conducted Peak Output Power

T	est Result	V		
	Mode	Channel	Conduct Peak Por	wer[dBm] Verdict
	BLE	LCH	0.421	PASS
<u>(1)</u>	BLE	МСН	-0.296	PASS
Y	BLE	нсн	-1.220	PASS

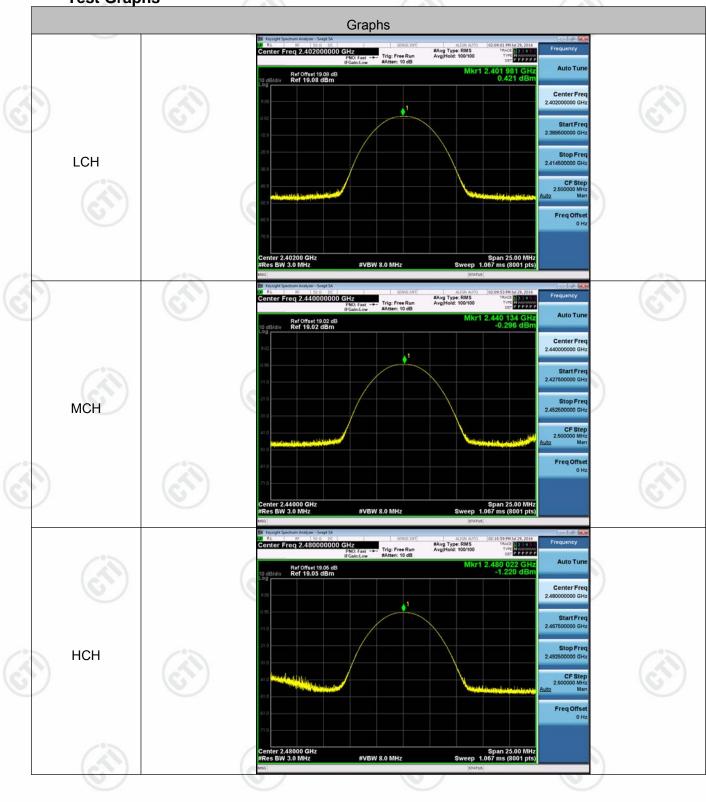






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Test Graphs











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Appendix C): Band-edge for RF Conducted Emissions

	Resu	It Table	V			
1	Mode	Channel	Carrier Power[dBm]	Max.Spurious Level [dBm]	Limit [dBm]	Verdict
6	BLE	LCH	0.213	-58.853	-19.79	PASS
C	BLE	нсн	-1.383	-57.104	-21.38	PASS

Test Graphs Graphs #Avg Type: RMS Avg|Hold: 100/10 Trig: Free Run #Atten: 10 dB Auto Tu Ref Offset 19.08 dE Ref 19.08 dBm Center Fr Start Fr LCH 2 400 000 2 390 000 2 389 24 -50.516 d -63.741 d -58.853 d Freq Offs #Avg Type: RMS Avg Hold: 100/100 er Freq 2.487500000 GHz Auto Tu Ref Offset 19.05 d Ref 19.05 dBm Center Fr Start Fr HCH CF Freq Offs





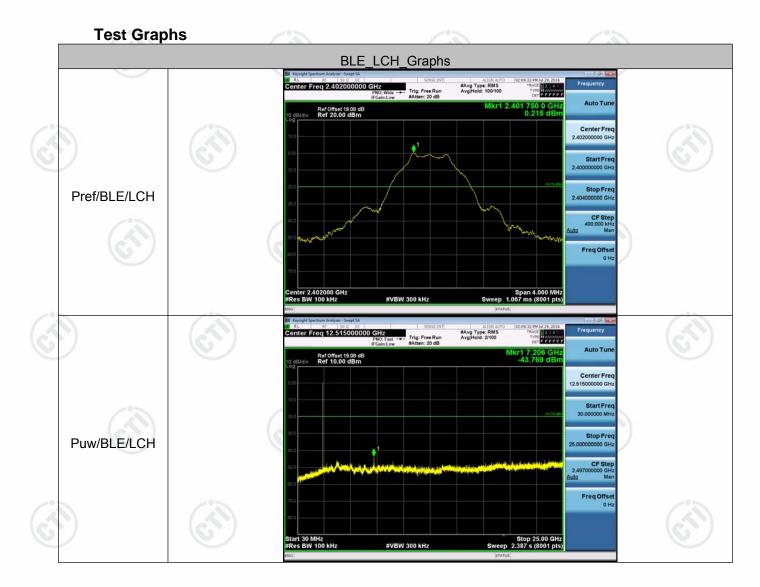




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Appendix D): RF Conducted Spurious Emissions

Result	Table		0	/
Mode	Channel	Pref [dBm]	Puw[dBm]	Verdict
BLE	LCH	0.215	<limit< td=""><td>PASS</td></limit<>	PASS
BLE	МСН	-0.514	<limit< td=""><td>PASS</td></limit<>	PASS
BLE	нсн	-1.454	<limit< td=""><td>PASS</td></limit<>	PASS





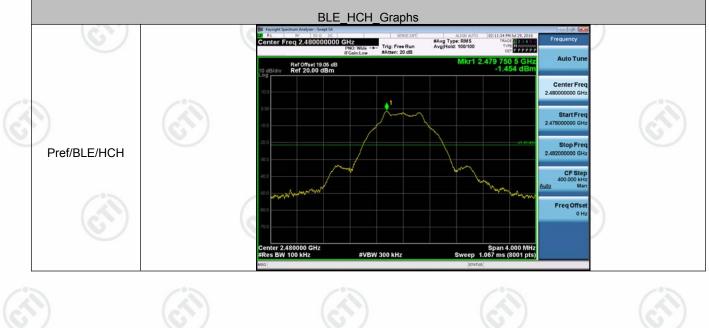






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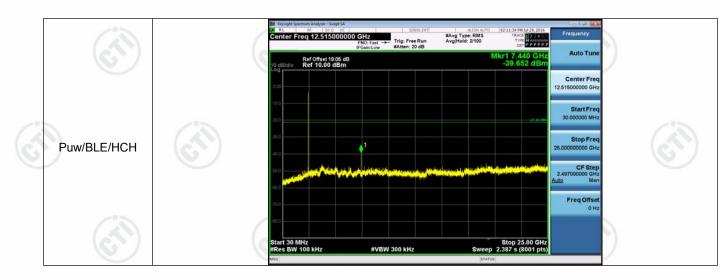


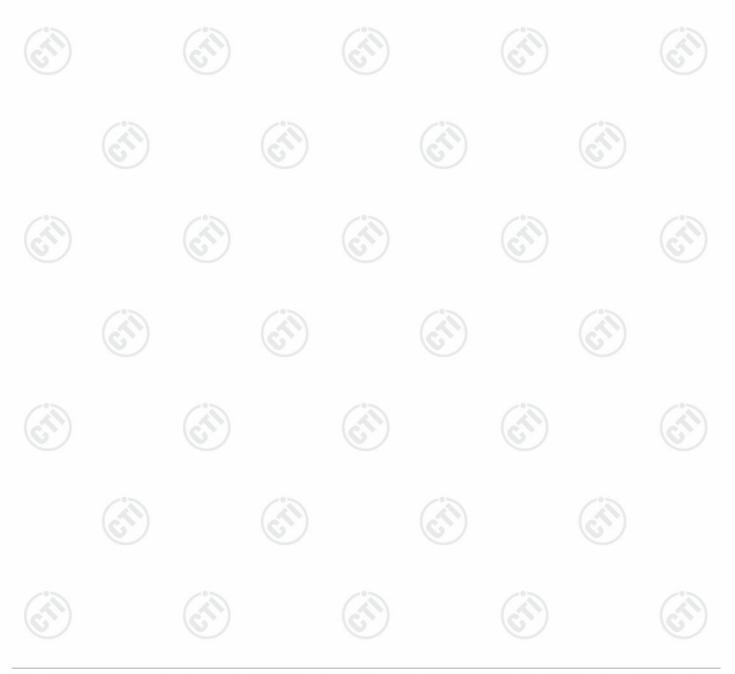






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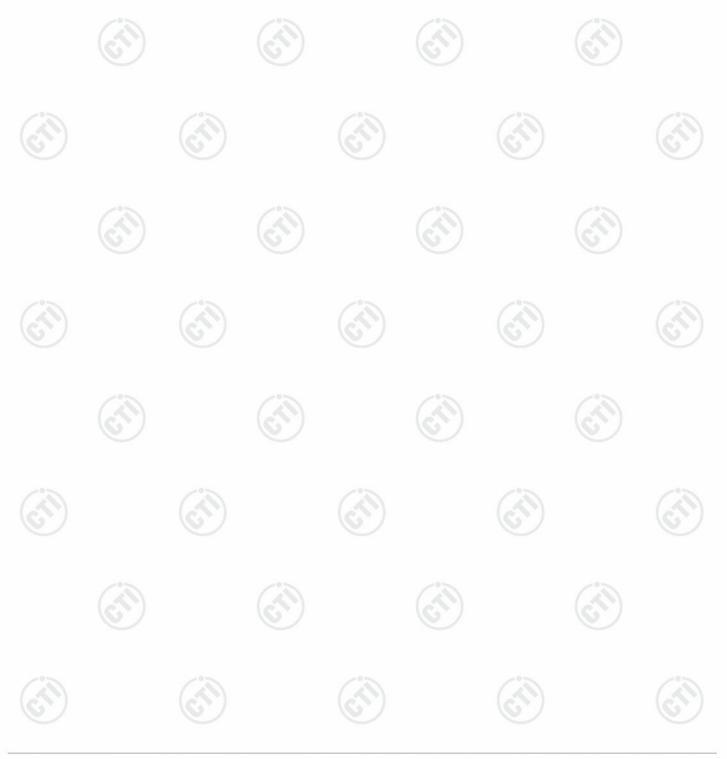






Appendix E): Power Spectral Density

Result Ta	ble			/
Mode	Channel	PSD [dBm/3kHz]	Limit [dBm/3kHz]	Verdict
BLE	LCH	-14.804	8	PASS
BLE	МСН	-15.663	8	PASS
BLE	НСН	-16.508	8	PASS

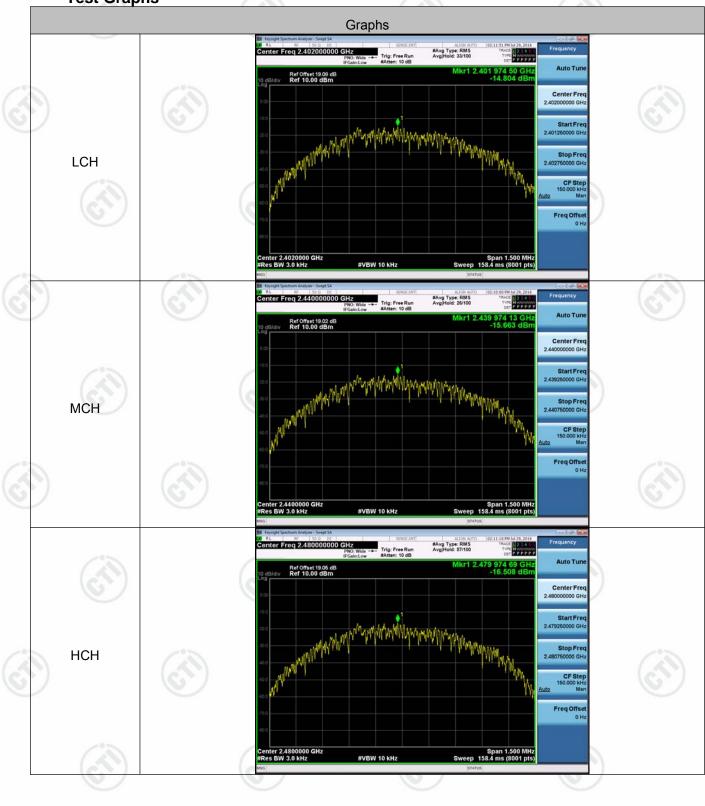






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Test Graphs







Appendix F): Antenna Requirement

15.203 requirement:

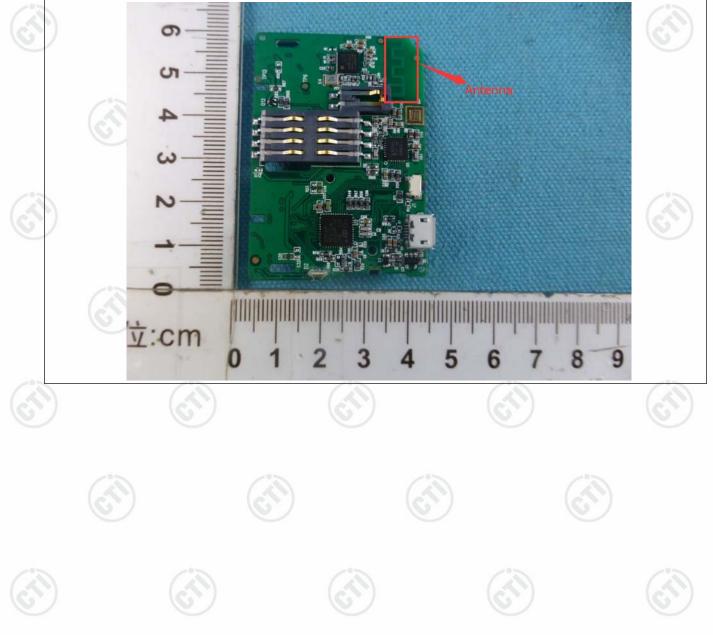
An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna car be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

15.247(b) (4) requirement:

The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentiona radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

EUT Antenna:

The antenna is Printed on the main PCB and no consideration of replacement. The best case gain of the antenna is 4dBi.







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Appendix G): AC Power Line Conducted Emission

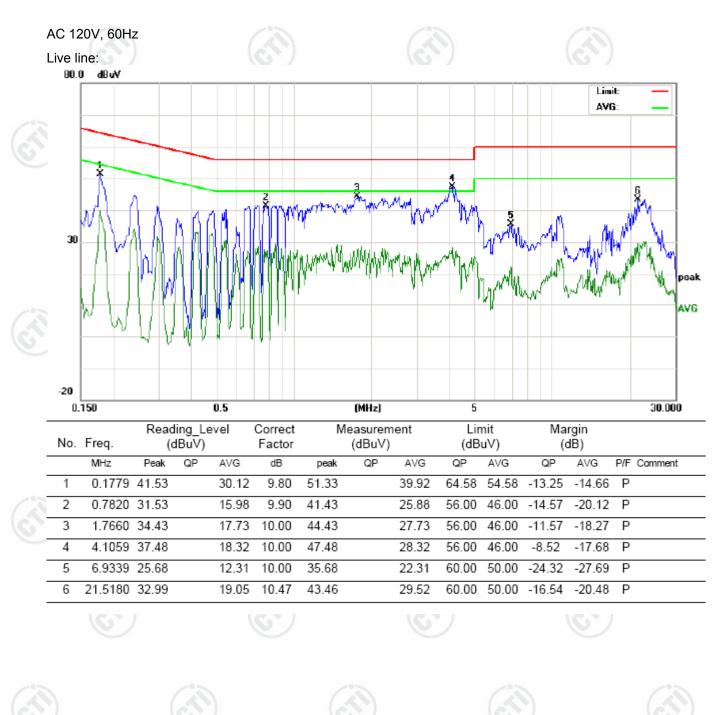
Trut David and				
Test Procedure:	Test frequency range :150KHz	-30MHz		
	1)The mains terminal disturbar	nce voltage test was	conducted in a shield	led room.
	2) The EUT was connected to Stabilization Network) which power cables of all other universe which was bonded to the grant for the unit being measured multiple power cables to a second device the second device t	h provides a 50Ω/50 nits of the EUT were round reference plar d. A multiple socket	$0\mu H + 5\Omega$ linear impose e connected to a sec ne in the same way a outlet strip was used	edance. cond LISN s the LISI d to conn
	exceeded. 3)The tabletop EUT was place reference plane. And for flo horizontal ground reference	or-standing arrange		
	 4) The test was performed with EUT shall be 0.4 m from the reference plane was bonded 1 was placed 0.8 m from the ground reference plane for plane. This distance was be All other units of the EUT at LISN 2. 	e vertical ground refe ed to the horizontal g the boundary of the or LISNs mounted etween the closest p	erence plane. The ve round reference plan unit under test and on top of the grour points of the LISN 1 a	rtical grou le. The LI bonded to nd referer and the EU
	5) In order to find the maximum		ive positions of equip according to ANSI	
	conducted measurement.	nust be changed		C63.10
Limit:		(c)	6.	C63.10
Limit:	conducted measurement.	Limit	(dBµV)	C63.10
Limit:	Frequency range (MHz)	Limit Quasi-peak	(dBµV) Average	C63.10
Limit:	conducted measurement.	Limit	(dBµV)	C63.10
Limit:	Frequency range (MHz)	Limit Quasi-peak	(dBµV) Average	C63.10
Limit:	conducted measurement. Frequency range (MHz) 0.15-0.5	Limit Quasi-peak 66 to 56*	(dBµV) Average 56 to 46*	C63.10

An initial pre-scan was performed on the live and neutral lines with peak detector.

Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission were detected.

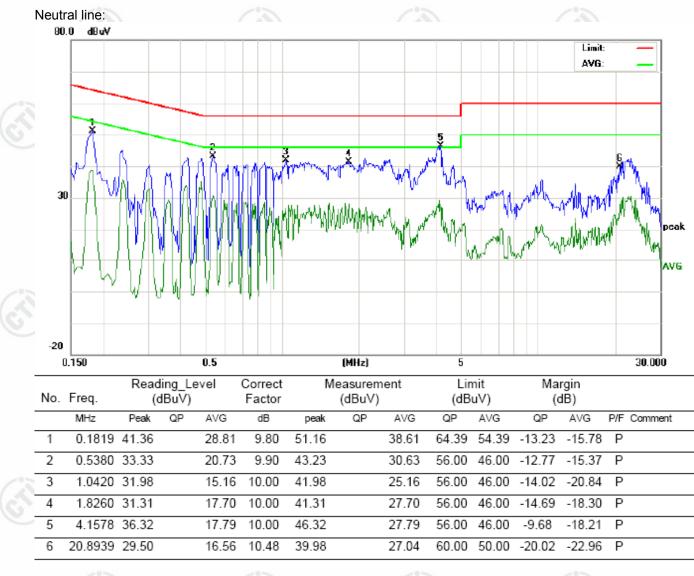


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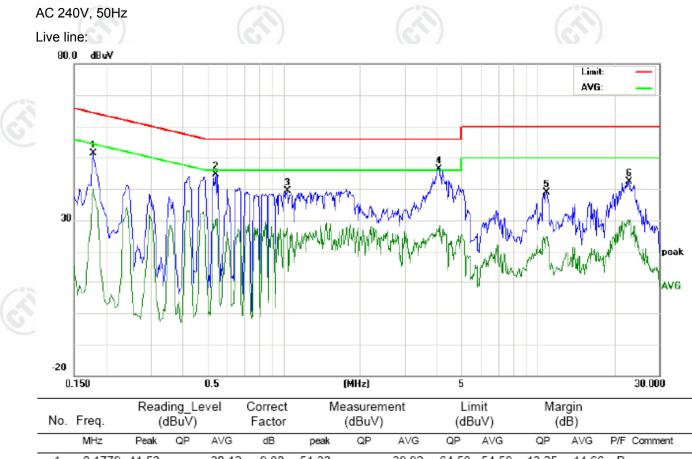
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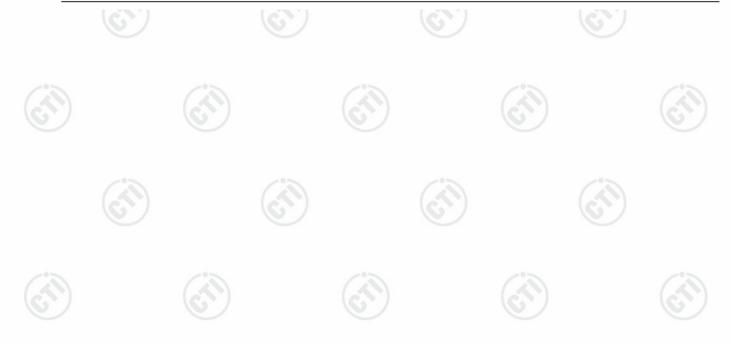




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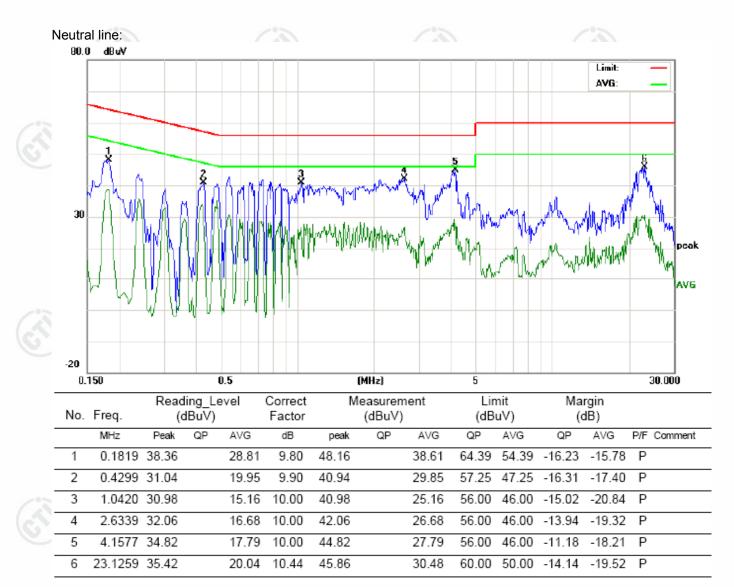


		MHz	Peak	QP	AVG	dB	peak	QP	AVG	QP	AVG	QP	AVG	P/F	Comment
	1	0.1779	41.53		30.12	9.80	51.33		39.92	64.58	54.58	-13.25	-14.66	Ρ	
3	2	0.5420	34.69		20.62	9.90	44.59		30.52	56.00	46.00	-11.41	-15.48	Ρ	
5	3	1.0420	29.46		17.53	10.00	39.46		27.53	56.00	46.00	-16.54	-18.47	Ρ	
<u> </u>	4	4.0819	36.50		16.37	10.00	46.50		26.37	56.00	46.00	-9.50	-19.63	Р	
_	5	10.8178	28.78		14.56	10.02	38.80		24.58	60.00	50.00	-21.20	-25.42	Р	
	6	22.9618	32.01		18.30	10.44	42.45		28.74	60.00	50.00	-17.55	-21.26	Ρ	





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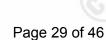
Notes:

1. The following Quasi-Peak and Average measurements were performed on the EUT:

2. Final Test Level =Receiver Reading + LISN Factor + Cable Loss.





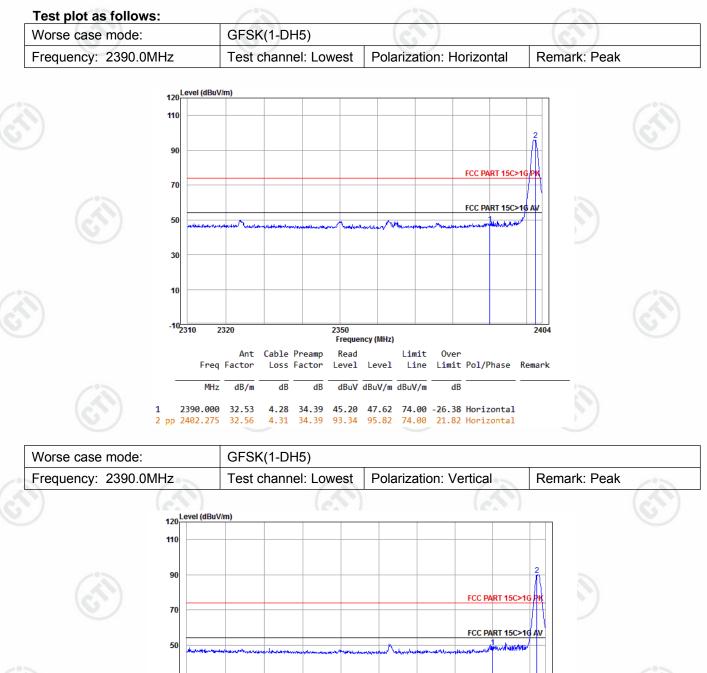


Appendix H): Restricted bands around fundamental frequency (Radiated)

Receiver Setup:	Frequency	Detector	RBW	VBW	Remark	
	30MHz-1GHz	Quasi-peak	120kHz	300kHz	Quasi-peak	
		Peak	1MHz	3MHz	Peak	10
	Above 1GHz	Peak	1MHz	10Hz	Average	6
Test Procedure:	Below 1GHz test proce	dure as below:	e e			e
	 a. The EUT was placed at a 3 meter semi-an determine the positio b. The EUT was set 3 m was mounted on the c. The antenna height i determine the maxim polarizations of the a d. For each suspected of the antenna was turned from 0 de e. The test-receiver system Bandwidth with Maxin f. Place a marker at the frequency to show corbands. Save the spe for lowest and highes 	on the top of a rota echoic camber. The n of the highest rac neters away from the top of a variable-he s varied from one n num value of the fiel ntenna are set to m emission, the EUT ed to heights from 1 egrees to 360 degree tem was set to Pea mum Hold Mode. e end of the restrict ompliance. Also me ctrum analyzer plot	e table wa diation. The interfere eight anter neter to fo d strength nake the m was arran I meter to sees to find ak Detect f ed band c asure any	s rotated 3 ence-receinna tower. ur meters b. Both hor heasurement ged to its w 4 meters a the maxim Function a	360 degrees to iving antenna, above the gro rizontal and ve ent. worst case an and the rotata num reading. nd Specified he transmit s in the restric	o , wh ouncertic d th ble
	Above 1GHz test proce g. Different between ab to fully Anechoic Cha 18GHz the distance i h Test the EUT in the i. The radiation measu Transmitting mode, a j. Repeat above procee	dure as below: ove is the test site, onber change form s 1 meter and table lowest channel, the rements are perform and found the X axis	table 0.8 is 1.5 met ie Highest ned in X, ` s positioni	meter to 1 er). channel Y, Z axis p ng which i	.5 meter(Abo positioning for t is worse cas	ove
Limit:	Above 1GHz test proce g. Different between ab to fully Anechoic Cha 18GHz the distance i h Test the EUT in the i. The radiation measu Transmitting mode, a	dure as below: ove is the test site, onber change form s 1 meter and table lowest channel, the rements are perform and found the X axis	table 0.8 is 1.5 met ned Highest med in X, ` s positioni encies me	meter to 1 er). channel Y, Z axis p ng which i asured wa	.5 meter(Abo positioning for t is worse cas	ove
Limit:	Above 1GHz test proce g. Different between ab to fully Anechoic Cha 18GHz the distance i h Test the EUT in the i. The radiation measu Transmitting mode, a j. Repeat above procee	dure as below: ove is the test site, mber change form s 1 meter and table lowest channel , the rements are perform and found the X axis dures until all freque	table 0.8 is 1.5 met ned Highest med in X, ` s positioni encies me	meter to 1 channel Y, Z axis p ng which i asured wa	.5 meter(Abo positioning for t is worse cas as complete.	ove
Limit:	Above 1GHz test proce g. Different between ab to fully Anechoic Cha 18GHz the distance i h Test the EUT in the i. The radiation measu Transmitting mode, a j. Repeat above procee	dure as below: ove is the test site, imber change form s 1 meter and table lowest channel , the rements are perform and found the X axis dures until all frequent Limit (dBµV/r	table 0.8 is 1.5 met ned Highest med in X, ` s positioni encies me	meter to 1 channel Y, Z axis p ng which i asured wa Rer Quasi-pe	.5 meter(Abo positioning for t is worse cas as complete.	ove
Limit:	Above 1GHz test proce g. Different between ab to fully Anechoic Cha 18GHz the distance i h Test the EUT in the i. The radiation measu Transmitting mode, a j. Repeat above proceed Frequency 30MHz-88MHz	dure as below: ove is the test site, amber change form s 1 meter and table lowest channel , th rements are perforr and found the X axis dures until all freque Limit (dBµV/r 40.0	table 0.8 is 1.5 met ned Highest med in X, ` s positioni encies me	meter to 1 er). channel Y, Z axis p ng which i asured wa Rer Quasi-pe	.5 meter(Abo positioning for t is worse cas as complete. mark eak Value	ove
Limit:	Above 1GHz test proce g. Different between ab to fully Anechoic Cha 18GHz the distance h Test the EUT in the i. The radiation measu Transmitting mode, a j. Repeat above proced Frequency 30MHz-88MHz 88MHz-216MHz	dure as below: ove is the test site, imber change form is 1 meter and table lowest channel , the rements are perform and found the X axis dures until all freque Limit (dBµV/m 40.0 43.5	table 0.8 is 1.5 met ned Highest med in X, ` s positioni encies me	meter to 1 er). channel Y, Z axis p ng which i asured wa Rer Quasi-pe Quasi-pe	.5 meter(Abo positioning for t is worse cas as complete. mark eak Value eak Value	ove
Limit:	Above 1GHz test proce g. Different between ab to fully Anechoic Cha 18GHz the distance i h Test the EUT in the i. The radiation measu Transmitting mode, a j. Repeat above procee Frequency 30MHz-88MHz 88MHz-216MHz 216MHz-960MHz	dure as below: ove is the test site, imber change form s 1 meter and table lowest channel , the rements are perform and found the X axis dures until all freque Limit (dBµV/m 40.0 43.5 46.0	table 0.8 is 1.5 met ned Highest med in X, ` s positioni encies me	meter to 1 channel Y, Z axis p ng which i asured wa Rer Quasi-pe Quasi-pe Quasi-pe	.5 meter(Abo positioning for t is worse cas as complete. mark eak Value eak Value eak Value	ove



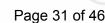
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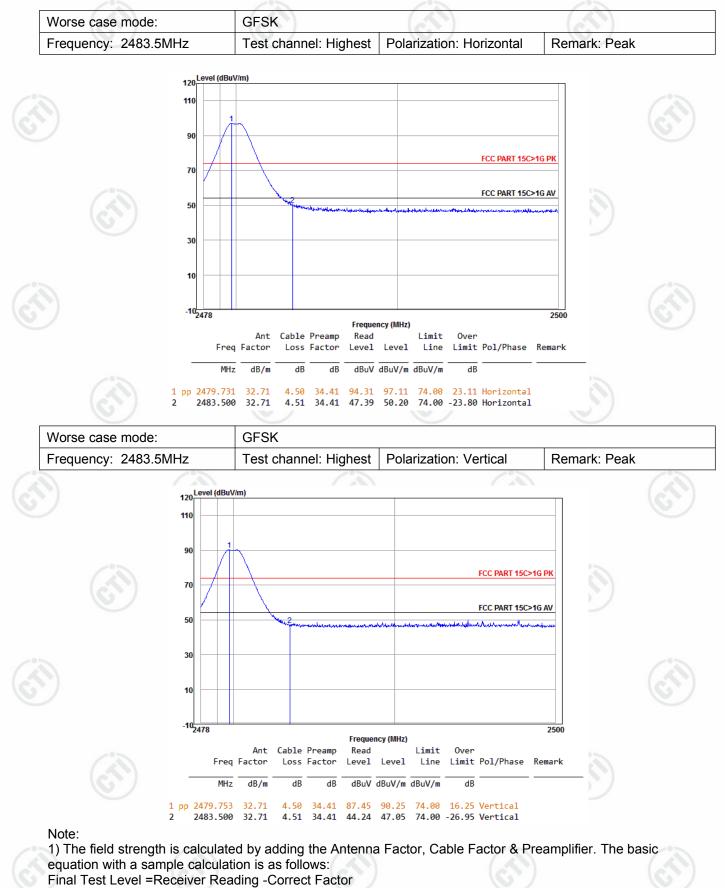


30 10 -102310 2320 2350 2404 Frequency (MHz) Cable Preamp Ant Read Limit 0ver Limit Pol/Phase Remark Freq Factor Loss Factor Level Level Line MHz dB/m dB dB dBuV dBuV/m dBuV/m dB 32.53 4.28 34.39 46.39 48.81 74.00 -25.19 Vertical 2390.000 1 34.39 87.48 89.96 74.00 15.96 Vertical pp 2401.796 32.56 4.31





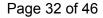




Correct Factor = Preamplifier Factor - Antenna Factor - Cable Factor







Appendix I): Radiated Spurious Emissions

Receiver Setup:	Frequency	Detector	RBW	VBW	Remark	
	0.009MHz-0.090MHz	Peak	10kHz	30kHz	Peak	
	0.009MHz-0.090MHz	Average	10kHz	30kHz	Average	
	0.090MHz-0.110MHz	Quasi-peak	10kHz	30kHz	Quasi-peak	
)	0.110MHz-0.490MHz	Peak	10kHz	30kHz	Peak	
	0.110MHz-0.490MHz	Average	10kHz	30kHz	Average	
	0.490MHz -30MHz	Quasi-peak	10kHz	30kHz	Quasi-peak	
(T)	30MHz-1GHz	Quasi-peak	120kHz	300kHz	Quasi-peak	
	Above 1GHz	Peak	1MHz	3MHz	Peak	
	Above IGHZ	Peak	1MHz	10Hz	Average	
			1			

Test Procedure:

Below 1GHz test procedure as below:

- The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic a. camber. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, whichwas mounted on the top of a variable-height antenna tower.
- The antenna height is varied from one meter to four meters above the ground to determine the maximum value C. of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rotatable was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode. e.
- If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be f. stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

Above 1GHz test procedure as below:

- Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber and g. change form table 0.8 meter to 1.5 meter(Above 18GHz the distance is 1 meter and table is 1.5 meter).
- Test the EUT in the lowest channel ,the middle channel ,the Highest channel h.
- The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X i. axis positioning which it is worse case. i

Denset chave	- nrooduroo	until all i	fraguianaiaa	manaurad	waa aamalata	
Repeat above	procedures	until all	requencies	measured	was complete.	

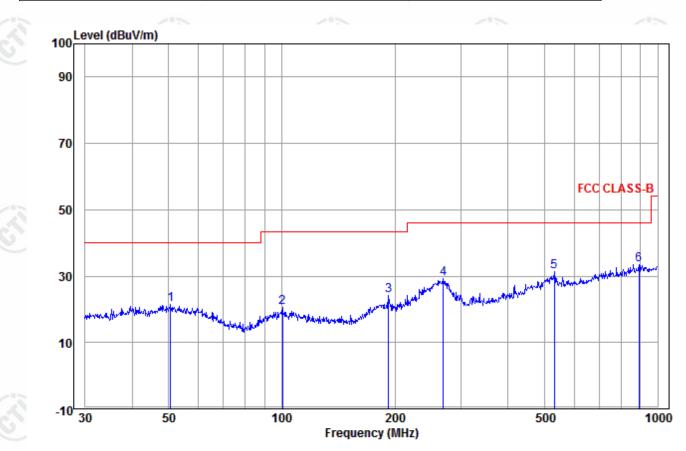
J. Repeat above p			e complete			-		
Limit:	Frequency	Field strength (microvolt/meter)	Limit (dBµV/m)	Remark	Measurement distance (m)			
	0.009MHz-0.490MHz	2400/F(kHz)	-	-	300	- 0 -		
	0.490MHz-1.705MHz	24000/F(kHz)	-		30			
	1.705MHz-30MHz	30	-	0	30	E.		
	30MHz-88MHz	100	40.0	Quasi-peak	3			
	88MHz-216MHz	150	43.5	Quasi-peak	3			
	216MHz-960MHz	200	46.0	Quasi-peak	3			
	960MHz-1GHz	500	54.0	Quasi-peak	3			
	Above 1GHz	500	54.0	Average	3			
	Note: 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.							





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	Radiated Spurious Emissions test Data: Radiated Emission below 1GHz				
30MHz~1GHz (QP)		C			
Test mode:	Transmitting	F	Horizontal		



	Freq		Cable Loss					Pol/Phase	Remark
-	MHz	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB		
1	50.586	15.02	1.40	5.14	21.56	40.00	-18.44	Horizontal	
2	100.581	13.15	1.57	5.98	20.70	43.50	-22.80	Horizontal	
3	192.419	11.34	2.13	10.76	24.23	43.50	-19.27	Horizontal	
4	269.428	12.85	2.36	14.04	29.25	46.00	-16.75	Horizontal	
5	531.964	18.53	3.18	9.63	31.34	46.00	-14.66	Horizontal	
6 рр	890.728	22.31	4.31	6.81	33.43	46.00	-12.57	Horizontal	

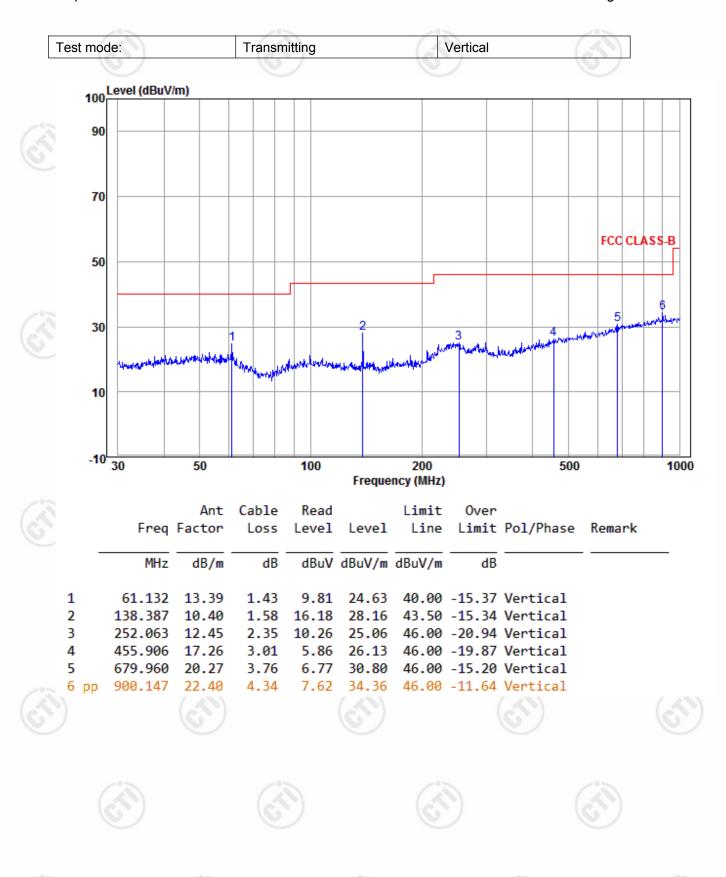








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Transmitter Emission above 1GHz

Worse case mode:		GFSK		Test channel:		Lowest	Remark: Peak		
Frequency (MHz)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Gain (dB)	Read Level (dBµV)	Level (dBµV/m)	Limit Line (dBµV/m)	Over Limit (dB)	Result	Antenna Polaxis
1296.469	30.45	2.62	34.86	44.35	42.56	74	-31.44	Pass	Н
1715.411	31.26	3.02	34.50	43.06	42.84	74	-31.16	Pass	Śн
3333.545	33.31	5.55	34.54	43.40	47.72	74	-26.28	Pass	Н
4804.000	34.69	5.11	34.35	41.36	46.81	74	-27.19	Pass	н
7206.000	36.42	6.66	34.90	38.11	46.29	74	-27.71	Pass	Н
9608.000	37.88	7.73	35.08	36.85	47.38	74	-26.62	Pass	н
1165.013	30.14	2.47	35.00	46.54	44.15	74	-29.85	Pass	V
1938.352	31.61	3.19	34.34	46.17	46.63	74	-27.37	Pass	V
3445.704	33.21	5.53	34.55	43.31	47.50	74	-26.50	Pass	V
4804.000	34.69	5.11	34.35	42.07	47.52	74	-26.48	Pass	V
7206.000	36.42	6.66	34.90	39.08	47.26	74	-26.74	Pass	V
9608.000	37.88	7.73	35.08	36.98	47.51	74	-26.49	Pass	V

1°2									
Worse case mode:		GFSK		Test chani	nel:	Middle	Remark: P	eak	
Frequency (MHz)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Gain (dB)	Read Level (dBµV)	Level (dBµV/m)	Limit Line (dBµV/m)	Over Limit (dB)	Result	Antenna Polaxis
1219.635	30.27	2.54	34.94	44.55	42.42	74	-31.58	Pass	H
1846.834	31.47	3.12	34.40	44.76	44.95	74	-29.05	Pass	Η
3893.520	32.88	5.46	34.59	42.25	46.00	74	-28.00	Pass	H
4880.000	34.85	5.08	34.33	41.74	47.34	74	-26.66	Pass	Н
7320.000	36.43	6.77	34.90	38.93	47.23	74	-26.77	Pass	Н
9760.000	38.05	7.60	35.05	38.31	48.91	74	-25.09	Pass	Н
1238.405	30.32	2.56	34.92	45.11	43.07	74	-30.93	Pass	V
1755.164	31.32	3.05	34.47	43.01	42.91	74	-31.09	Pass	V
3367.661	33.28	5.55	34.54	43.98	48.27	74	-25.73	Pass	V
4880.000	34.85	5.08	34.33	41.70	47.30	74	-26.70	Pass	V
7320.000	36.43	6.77	34.90	38.61	46.91	74	-27.09	Pass	V
9760.000	38.05	7.60	35.05	37.14	47.74	74	-26.26	Pass	V





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			10						
Worse case mode:		ase mode: GFSK		Test channel: Highest		Highest	Remark: Peak		
Frequency (MHz)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Gain (dB)	Read Level (dBµV)	Level (dBµV/m)	Limit Line (dBµV/m)	Over Limit (dB)	Result	Antenna Polaxis
1323.141	30.51	2.65	34.84	44.67	42.99	74	-31.01	Pass	н
1884.829	31.53	3.15	34.38	43.42	43.72	74	-30.28	Pass	H)
3903.444	32.87	5.46	34.59	42.55	46.29	74	-27.71	Pass	Ч
4960.000	35.02	5.05	34.31	40.78	46.54	74	-27.46	Pass	Н
7440.000	36.45	6.88	34.90	38.56	46.99	74	-27.01	Pass	Н
9920.000	38.22	7.47	35.02	37.44	48.11	74	-25.89	Pass	Н
1316.422	30.49	2.64	34.84	43.92	42.21	74	-31.79	Pass	V
1938.352	31.61	3.19	34.34	43.96	44.42	74	-29.58	Pass	V
3428.206	33.23	5.54	34.55	42.34	46.56	74	-27.44	Pass	V
4960.000	35.02	5.05	34.31	40.35	46.11	74	-27.89	Pass	V
7440.000	36.45	6.88	34.90	39.19	47.62	74	-26.38	Pass	V
9920.000	38.22	7.47	35.02	37.01	47.68	74	-26.32	Pass	V

Note:

1)The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:

Final Test Level =Receiver Reading -Correct Factor

Correct Factor = Preamplifier Factor-Antenna Factor-Cable Factor

2) Scan from 9kHz to 25GHz, the disturbance above 13GHz and below 30MHz was very low, and the above harmonics were the highest point could be found when testing, so only the above harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

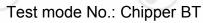






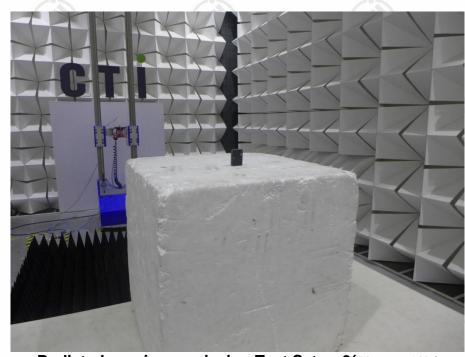
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PHOTOGRAPHS OF TEST SETUP





Radiated spurious emission Test Setup-1(Below 1GHz)



Radiated spurious emission Test Setup-2(Above 1GHz)

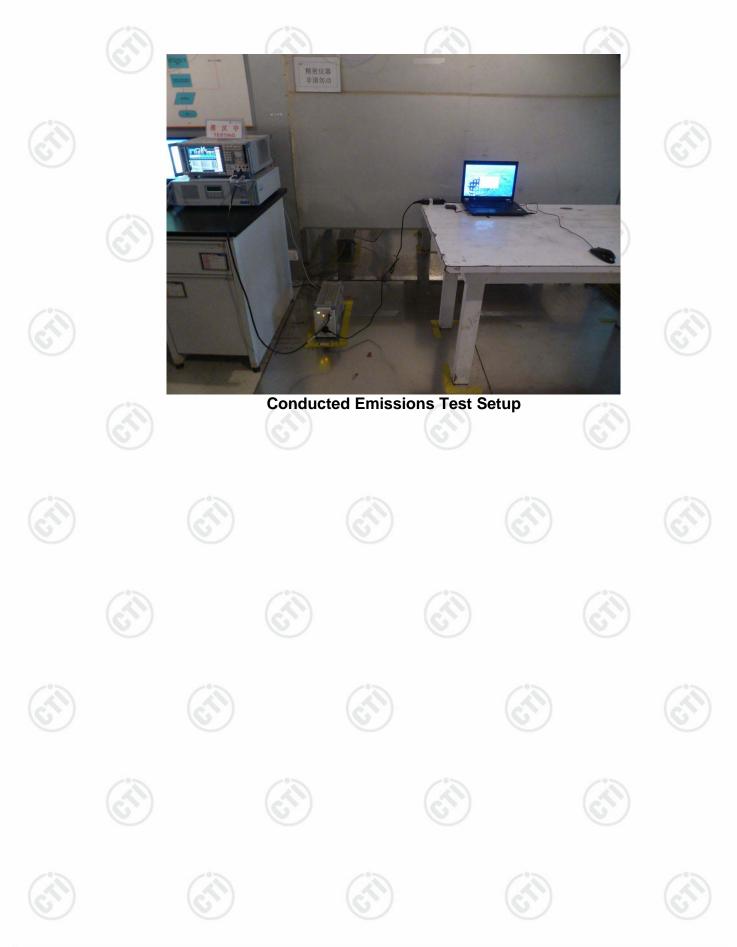


















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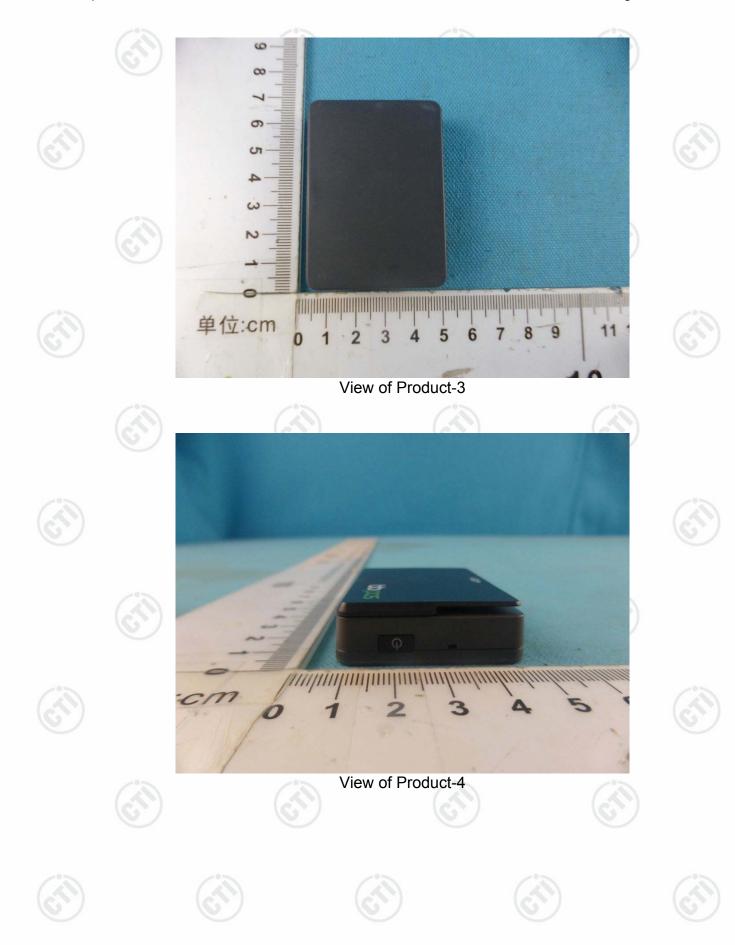








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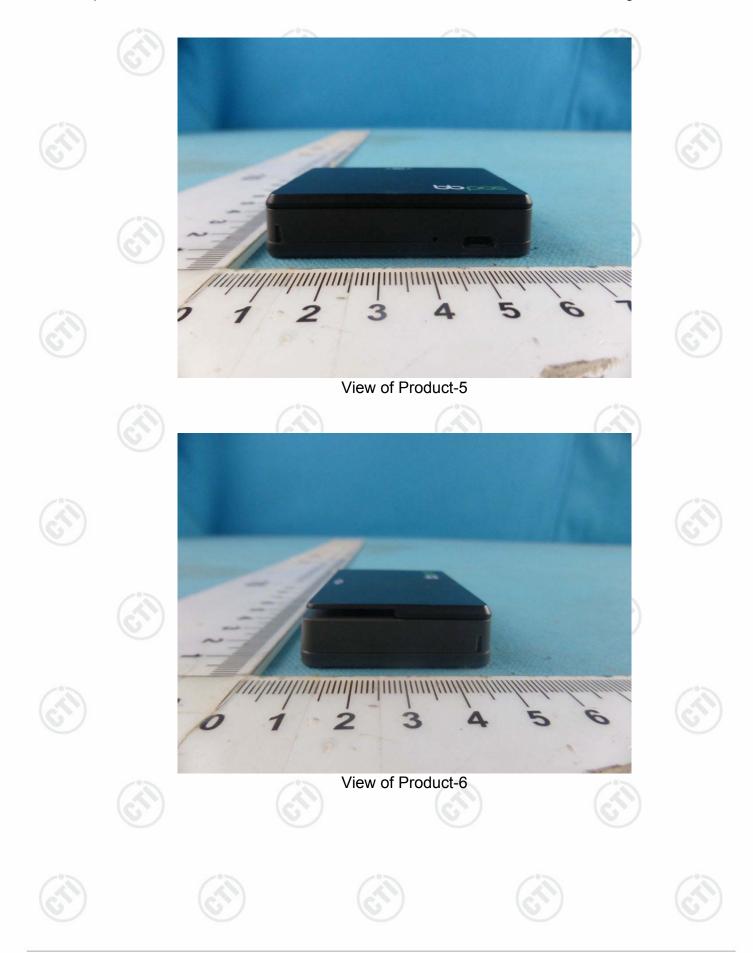








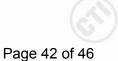




















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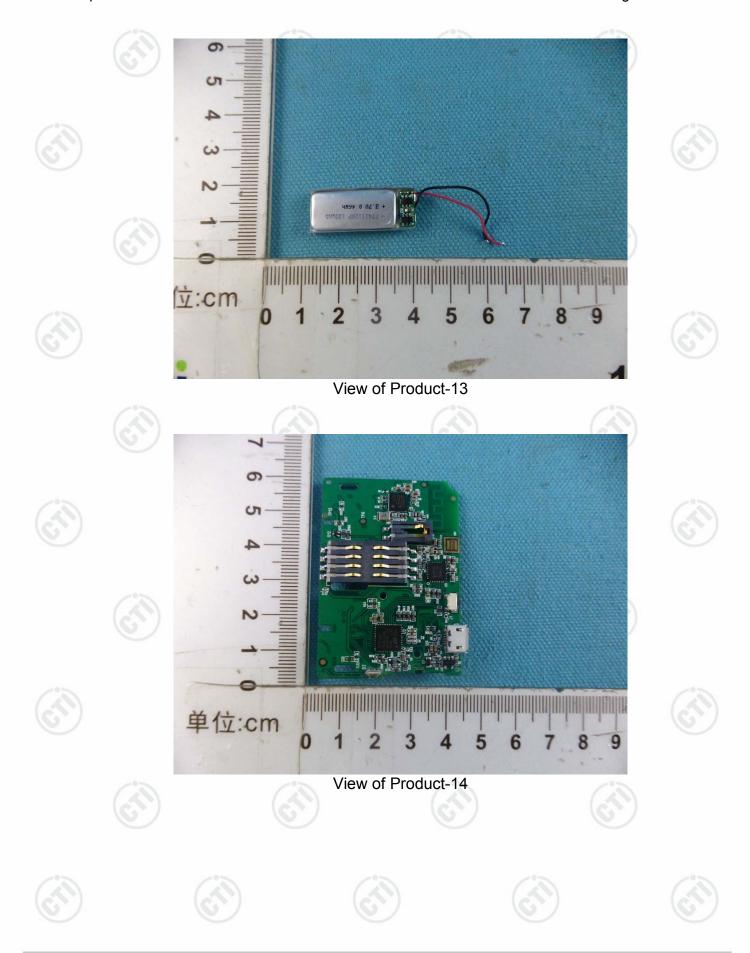








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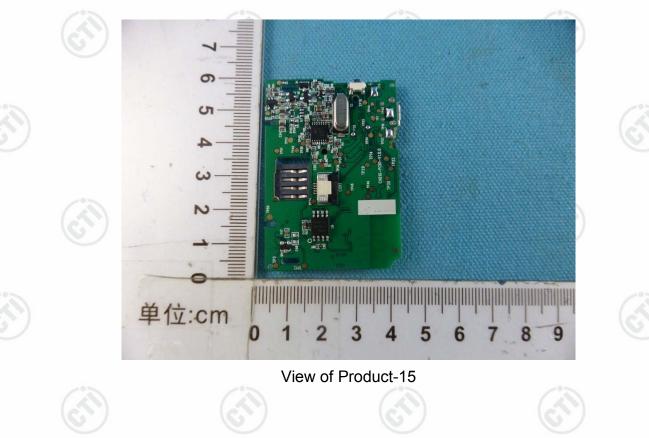












*** End of Report ***

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